

FDMC6675BZ

June 2014

P-Channel PowerTrench[®] MOSFET -30 V, -20 A, 14.4 m Ω

Features

- Max $r_{DS(on)}$ = 14.4 m Ω at V_{GS} = -10 V, I_D = -9.5 A
- Max $r_{DS(on)}$ = 27.0 m Ω at V_{GS} = -4.5 V, I_D = -6.9 A
- HBM ESD protection level of 8 kV typical(note 3)
- Extended V_{GSS} range (-25 V) for battery applications
- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability
- Termination is Lead-free and RoHS Compliant

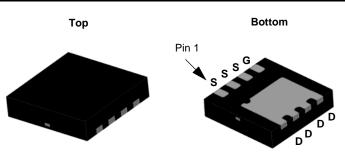
General Description

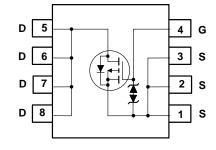
The FDMC6675BZ has been designed to minimize losses in load switch applications. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{\text{DS(on)}}$ and ESD protection.

Application

- Load Switch in Notebook and Server
- Notebook Battery Pack Power Management







MLP 3.3x3.3

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

| Symbol | Parai | | Ratings | Units | |
|-------------------|--------------------------------------|------------------------|-----------|-------------|----|
| V_{DS} | Drain to Source Voltage | | | -30 | V |
| V_{GS} | Gate to Source Voltage | | | ±25 | V |
| | Drain Current -Continuous | T _C = 25 °C | | -20 | |
| I_D | -Continuous | T _A = 25 °C | (Note 1a) | -9.5 | Α |
| | -Pulsed | | | -32 | |
| D | Power Dissipation | T _C = 25 °C | | 36 | W |
| P_{D} | Power Dissipation | T _A = 25 °C | (Note 1a) | 2.3 | VV |
| T_J , T_{STG} | Operating and Storage Junction Tempe | rature Range | | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 3.4 | °C/W |
|-----------------|---|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 53 | C/VV |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|------------|-------------|-----------|------------|------------|
| FDMC6675BZ | FDMC6675BZ | MLP 3.3X3.3 | 13 " | 12 mm | 3000 units |

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|---------------------------------------|--|--|-----|-----|------------|-------|
| Off Chara | acteristics | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = -250 \mu A, V_{GS} = 0 V$ | -30 | | | V |
| $\frac{\Delta BV_{DS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | I_D = -250 μ A, referenced to 25 °C | | 20 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = -24 \text{ V},$ $V_{GS} = 0 \text{ V}$ $T_1 = 125 \text{ °C}$ | | | -1 -100 | μА |
| I _{GSS} | Gate to Source Leakage Current | V _{GS} = ±25 V, V _{DS} = 0 V | | | ±10 | μА |

On Characteristics

| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = -250 \mu A$ | -1.0 | -1.9 | -3.0 | V |
|---|---|--|------|------|------|-------|
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | I_D = -250 μ A, referenced to 25 °C | | -6 | | mV/°C |
| | | $V_{GS} = -10 \text{ V}, I_D = -9.5 \text{ A}$ | | 10.7 | 14.4 | |
| r _{DS(on)} Static Drain to Sou | Static Drain to Source On Resistance | $V_{GS} = -4.5 \text{ V}, I_D = -6.9 \text{ A}$ | | 17.4 | 27.0 | mΩ |
| | | $V_{GS} = -10 \text{ V}, I_D = -9.5 \text{ A}, T_J = 125 \text{ °C}$ | | 15.2 | 20.5 | |
| 9 _{FS} | Forward Transconductance | $V_{DD} = -5 \text{ V}, \ I_{D} = -9.5 \text{ A}$ | | 28 | | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | V 45 V V 0 V | 2154 | 2865 | pF |
|------------------|------------------------------|--|------|------|----|
| C _{oss} | Output Capacitance | $V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz | 392 | 525 | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 - 1 101112 | 349 | 525 | pF |

Switching Characteristics

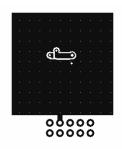
| t _{d(on)} | Turn-On Delay Time | | | | 11 | 20 | ns |
|---------------------|-------------------------------|--------------------------------------|--|--|-----|----|----|
| t _r | Rise Time | $V_{DD} = -15 \text{ V}, I_{D} = -9$ | V_{DD} = -15 V, I_{D} = -9.5 A, V_{GS} = -10 V, R_{GEN} = 6 Ω | | 10 | 20 | ns |
| t _{d(off)} | Turn-Off Delay Time | $V_{GS} = -10 \text{ V}, R_{GEN}$ | | | 44 | 71 | ns |
| t _f | Fall Time | | | | 26 | 42 | ns |
| 0 | Total Gate Charge | $V_{GS} = 0 \text{ V to -10 V}$ | | | 46 | 65 | nC |
| $Q_{g(TOT)}$ | Total Gate Charge | $V_{GS} = 0 \text{ V to -5 V}$ | V _{DD} = -15 V, | | 26 | 37 | nC |
| Q_{gs} | Gate to Source Charge | | I _D = -9.5 A | | 6.4 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | | | | 13 | | nC |

Drain-Source Diode Characteristics

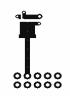
| V _{SD} Source to Drain Diode Forward Voltage | Source to Drain Diode, Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = -9.5 \text{ A}$ (Note 2) | | 0.89 | 1.3 | V |
|---|---|---|------|------|-----|----|
| | $V_{GS} = 0 \text{ V}, I_{S} = -1.6 \text{ A}$ (Note 2) | | 0.73 | 1.2 | V | |
| t _{rr} | Reverse Recovery Time | -I _F = -9.5 A, di/dt = 100 A/μs | | 24 | 38 | ns |
| Q _{rr} | Reverse Recovery Charge | | | 15 | 27 | nC |

NOTES

^{1.} R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in² pad of 2 oz copper



b.125 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0 %.
- 3. The diode connected between the gate and source servers only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25 °C unless otherwise noted

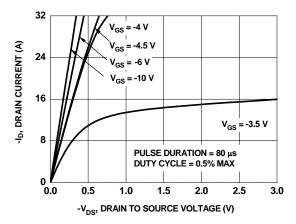


Figure 1. On Region Characteristics

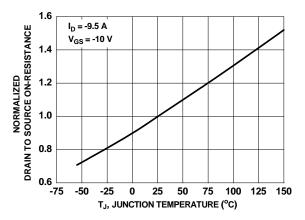


Figure 3. Normalized On Resistance vs Junction Temperature

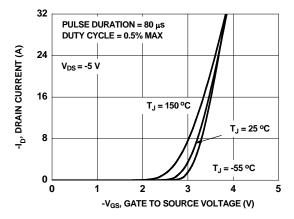


Figure 5. Transfer Characteristics

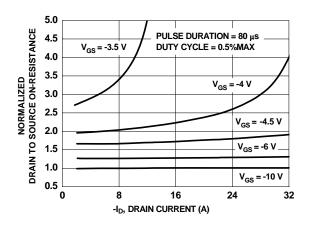


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

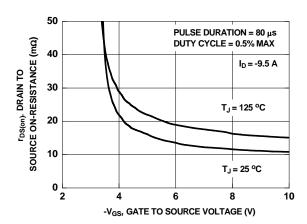


Figure 4. On-Resistance vs Gate to Source Voltage

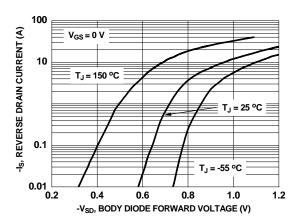


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

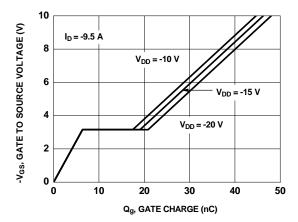


Figure 7. Gate Charge Characteristics

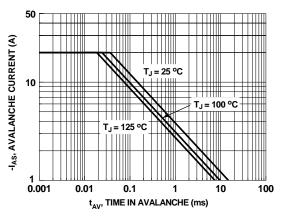


Figure 9. Unclamped Inductive Switching Capability

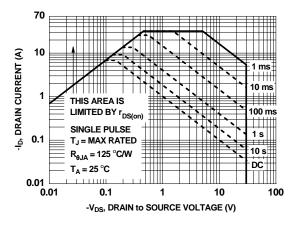


Figure 11. Forward Bias Safe Operating Area

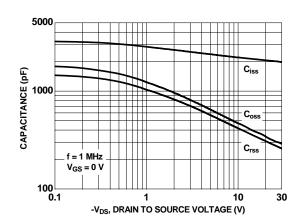


Figure 8. Capacitance vs Drain to Source Voltage

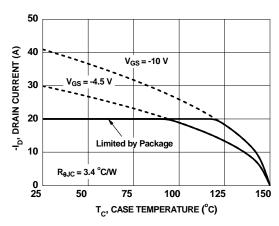


Figure 10. Maximum Continuous Drain Current vs Case Temperature

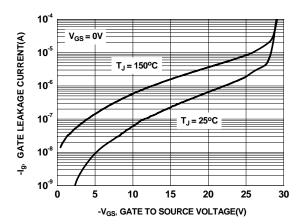


Figure 12. I_{qss} vs V_{qss}

Typical Characteristics $T_J = 25$ °C unless otherwise noted

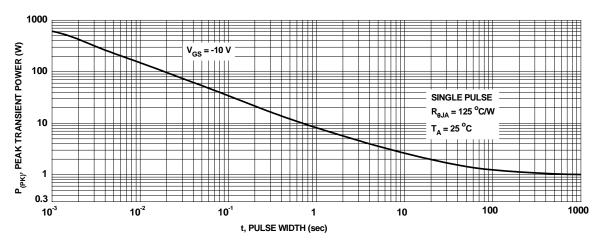


Figure 13. Single Pulse Maximum Power Dissipation

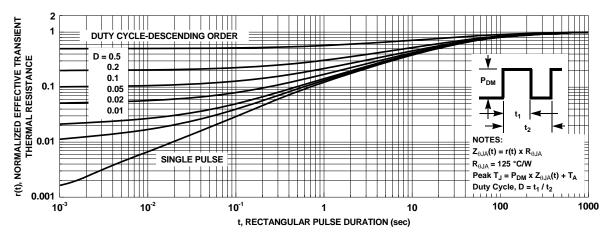
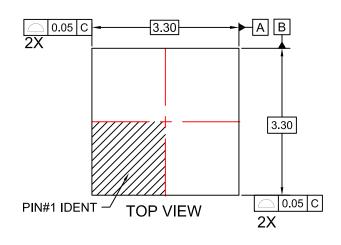
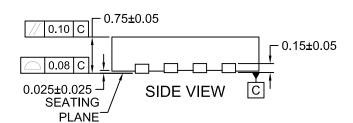
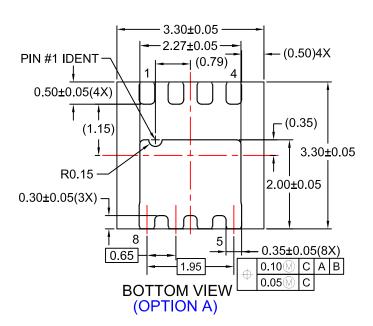
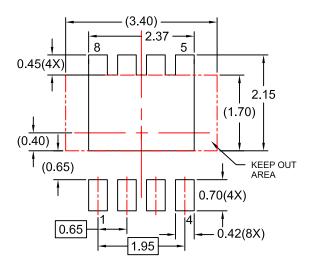


Figure 14. Junction-to-Ambient Transient Thermal Response Curve

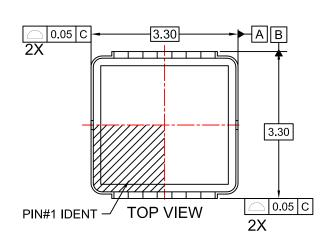


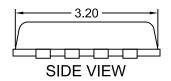


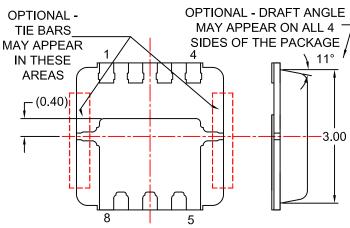




RECOMMENDED LAND PATTERN

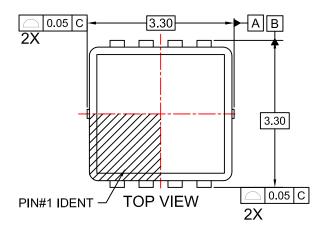


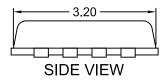


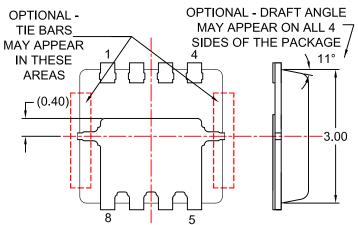


ALL DIMENSIONS AS PER OPTION A
UNLESS SPECIFIED
BOTTOM VIEW
(OPTION B)









ALL DIMENSIONS AS PER OPTION A
UNLESS SPECIFIED
BOTTOM VIEW
(OPTION C)

NOTES:

- A. PACKAGE DOES NOT FULLY CONFORM TO JEDEC REGISTRATION MO-240.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN
- E. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. BURRS OR MOLD FLASH SHALL NOT EXCEED 0.10MM.
- F. DRAWING FILENAME: MKT-MLP08Wrev3.
- G. OPTION A SAWN MLP, OPTIONS B & C PUNCH MLP.







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